

Status Report 1999 HEC Beam Test Data Analysis

Marseille
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Started to look at the electron data

- Just using pedestal subtracted adc.
- Essentially looking at data quality.
- Going through all selected impact points, so far points B, F (June 99)
points C, G (August 99).
- Cell 61 requires an extra factor of 2 (2.12 ± 0.17).
- Response and resolution: no surprises.

Started to look at pion data

- Shapes for π^+ contamination of e^+ : small effect.

Future: Refine analysis using weights and calibration

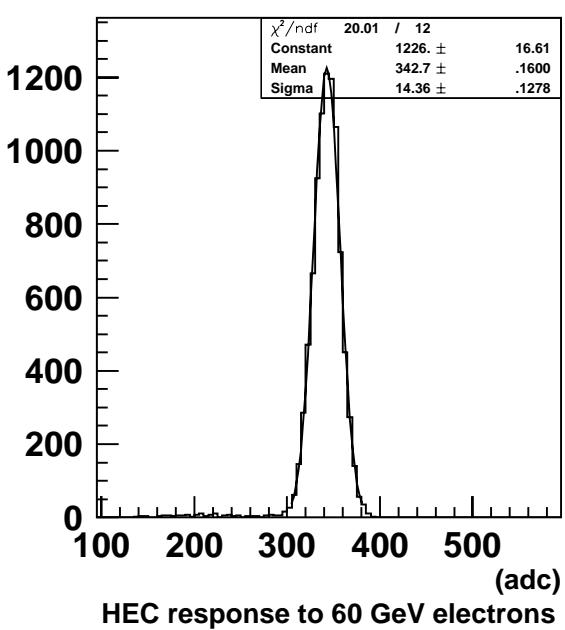
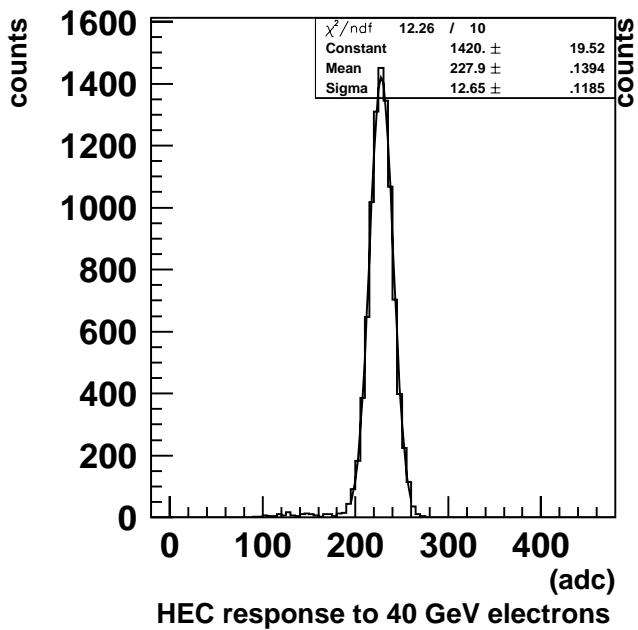
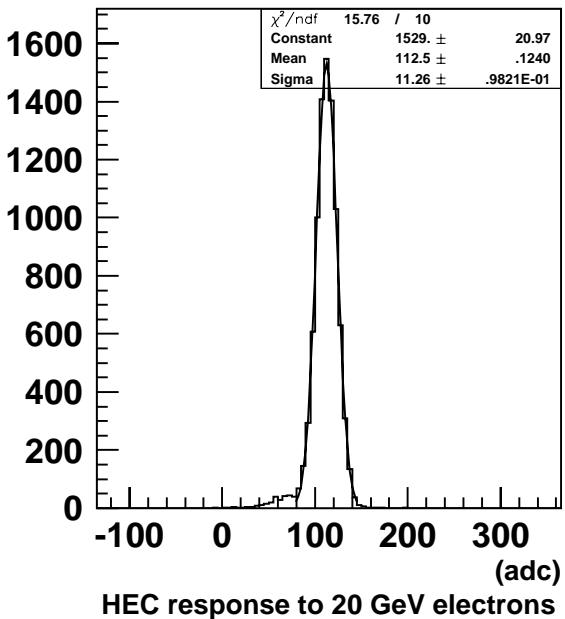
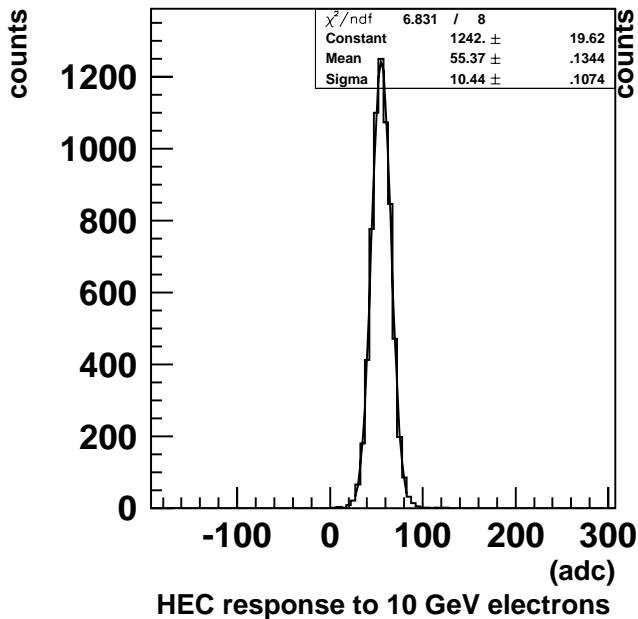
- Look at noise.
- e^+ : response and resolution.
- π^+ : response and resolution.
- etc.

Electron Data

August 99, impact point G

99/10/05 13.31

impact point ge39 is used



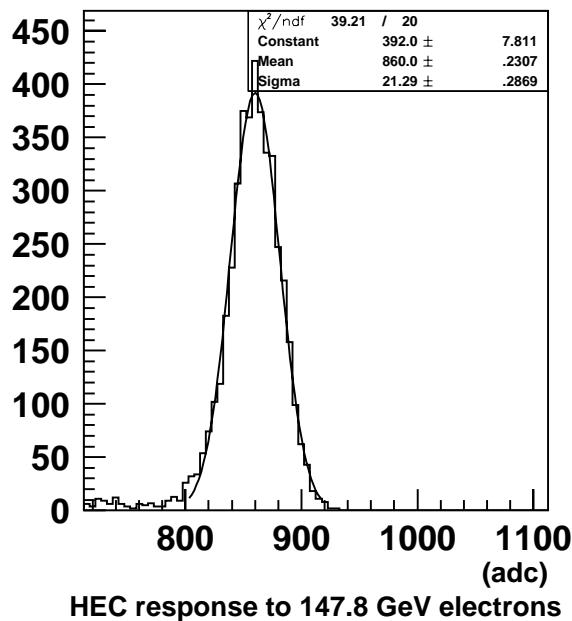
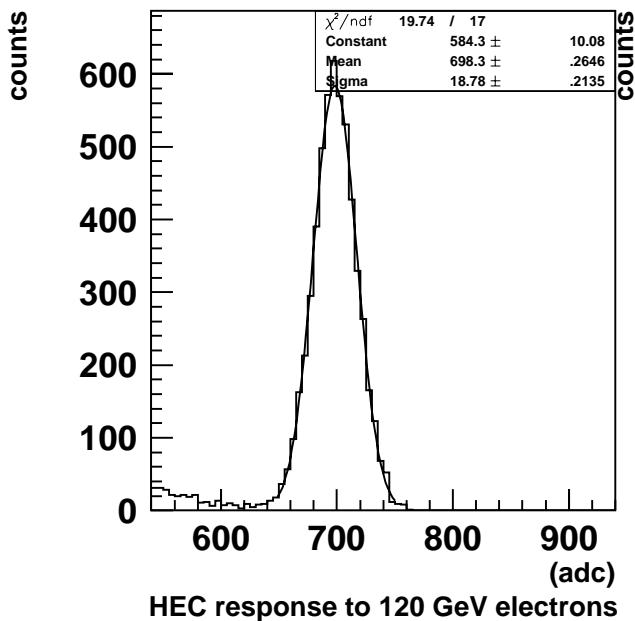
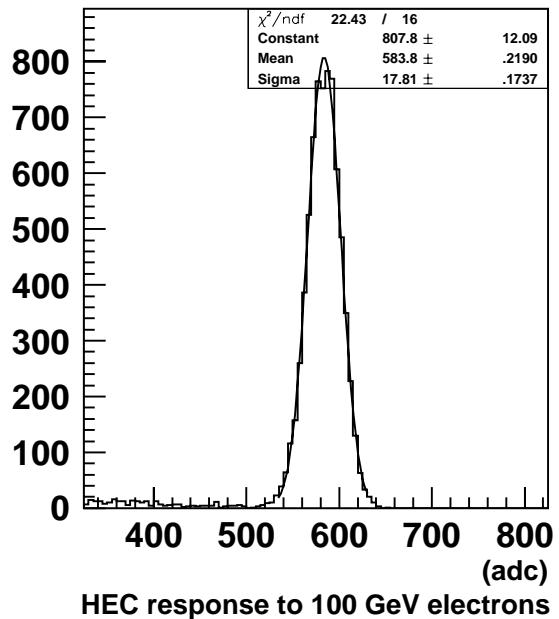
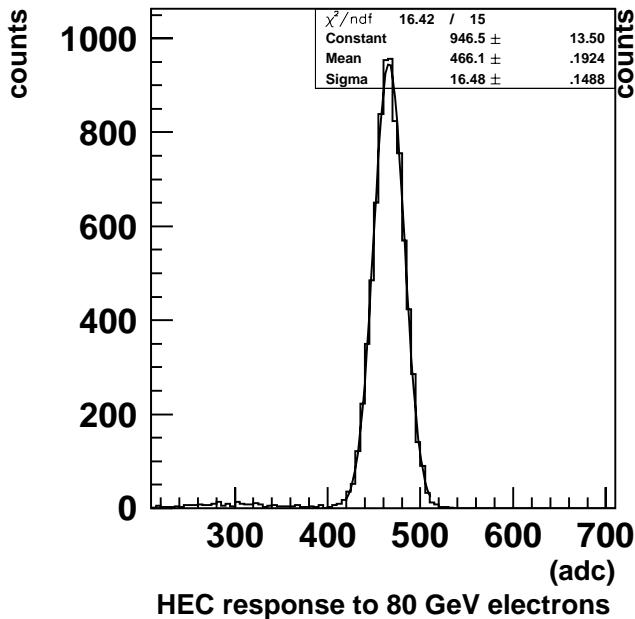
Signal (adc) distribution for
 e^+ of 10, 20, 40 and 60 GeV.

Electron Data

August 99, impact point G

99/10/05 13.31

impact point ge39 is used



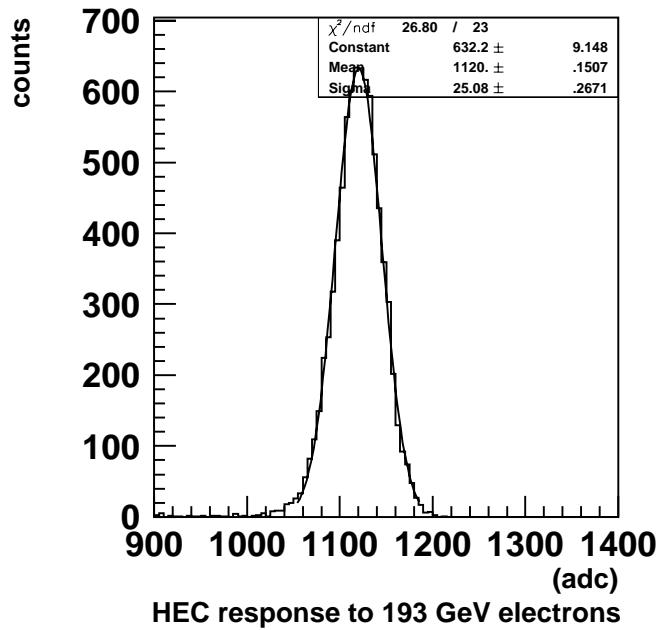
Signal (adc) distribution for
 e^+ of 80, 100, 120 and 147.8 GeV.

Electron Data

August 99, impact point G

99/10/05 13.31

impact point ge39 is used



Signal (adc) distribution for e^+ of 193 GeV.

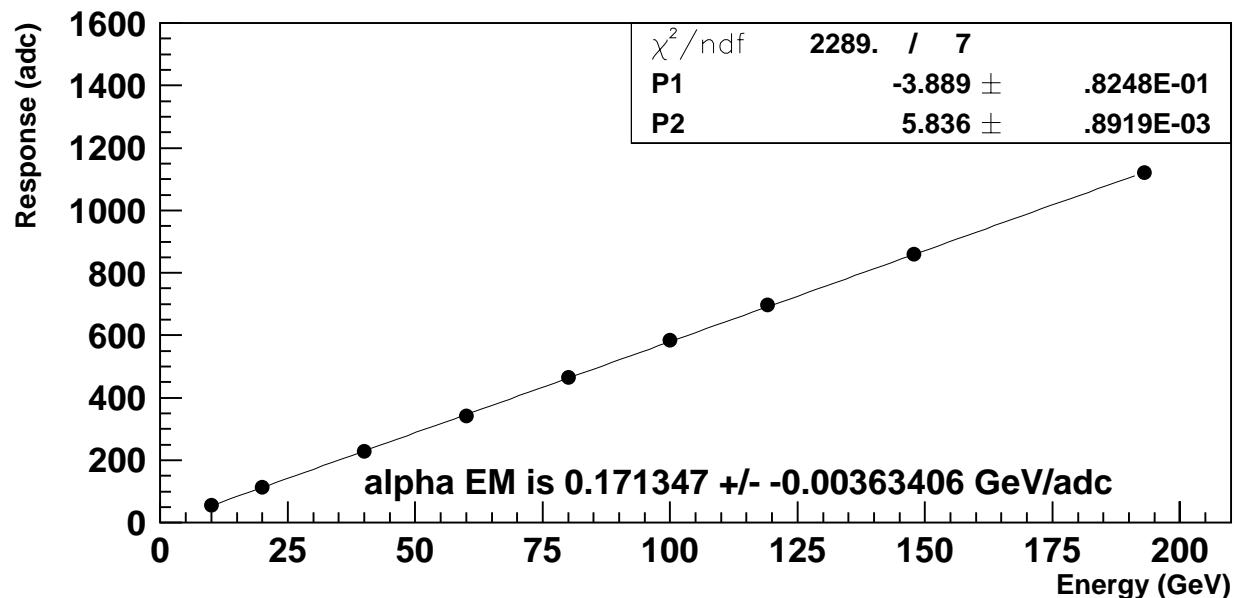
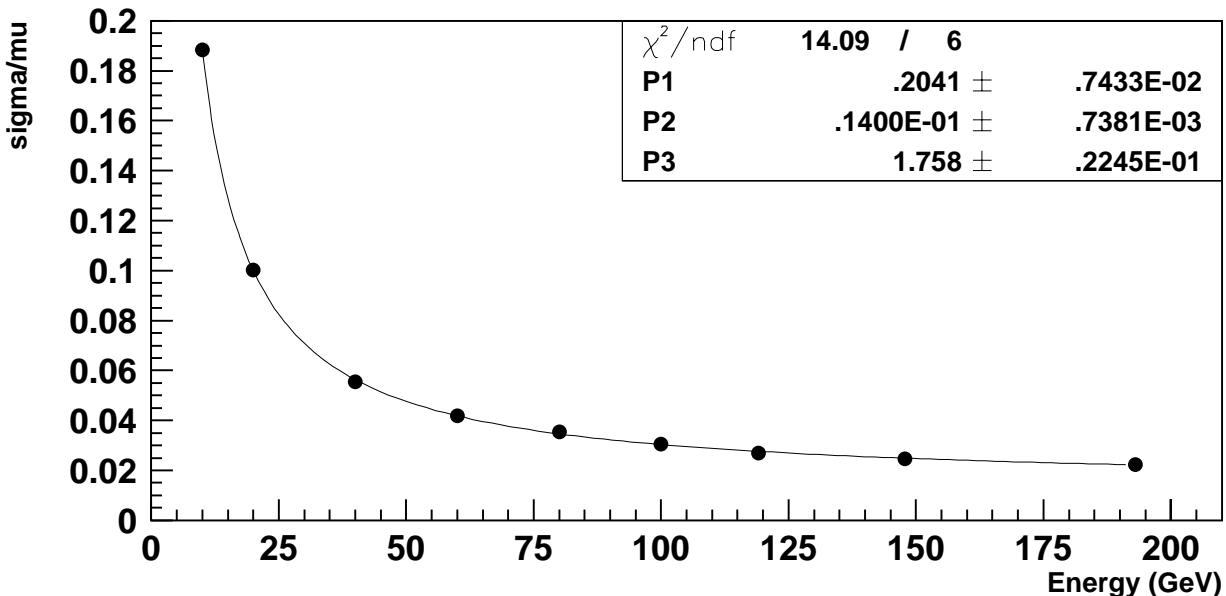
Electron Data

August 99, impact point G

Resolution and Response

99/10/05 13.31

impact point ge39 is used



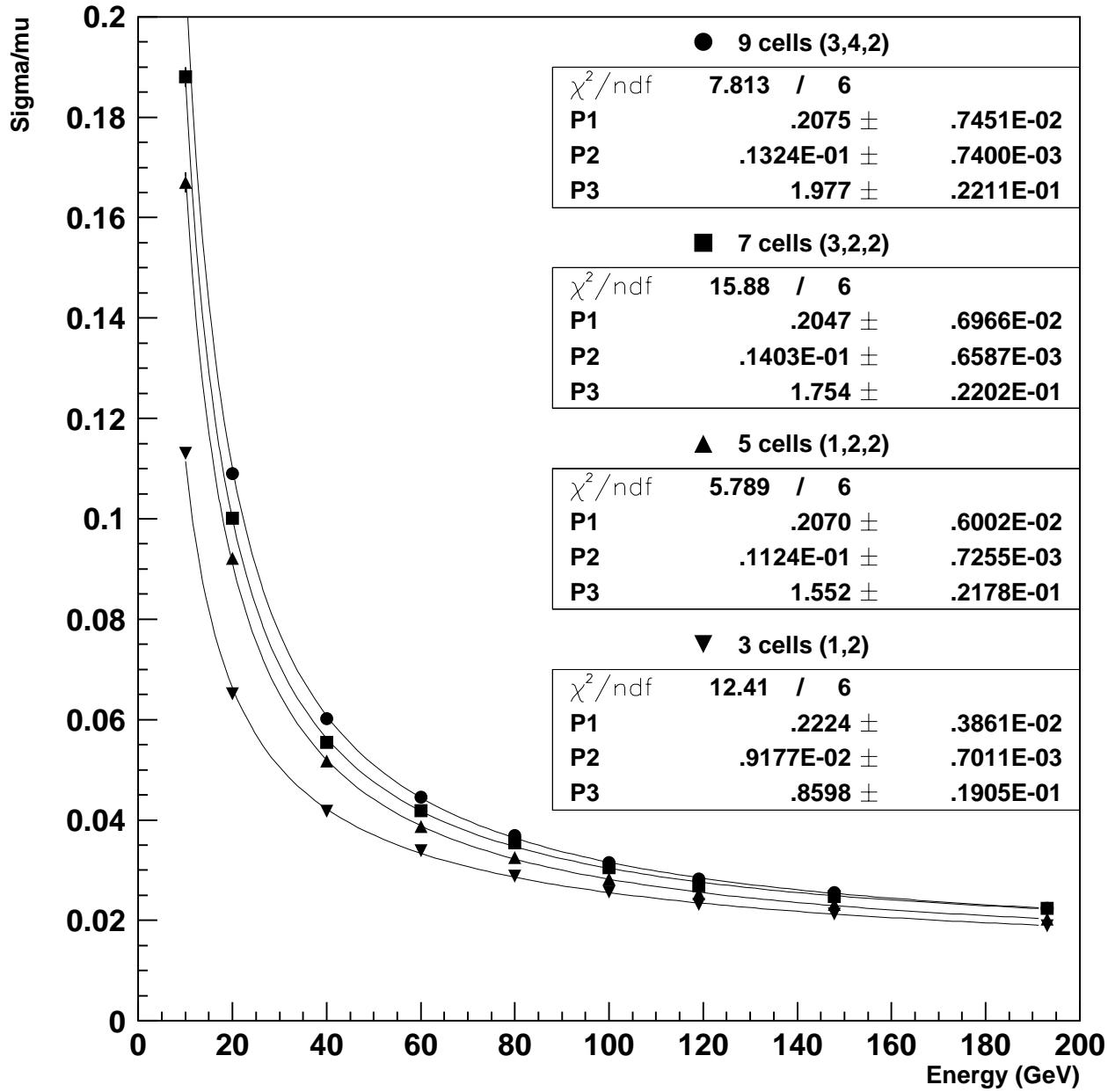
No surprises...

Electron Data

August 99, impact point G

99/10/05 14.17

Resolution points for 4 different cluster sizes (impact G)



Sampling term: worse for 3 cell cluster
 Electronics noise: worse for bigger clusters

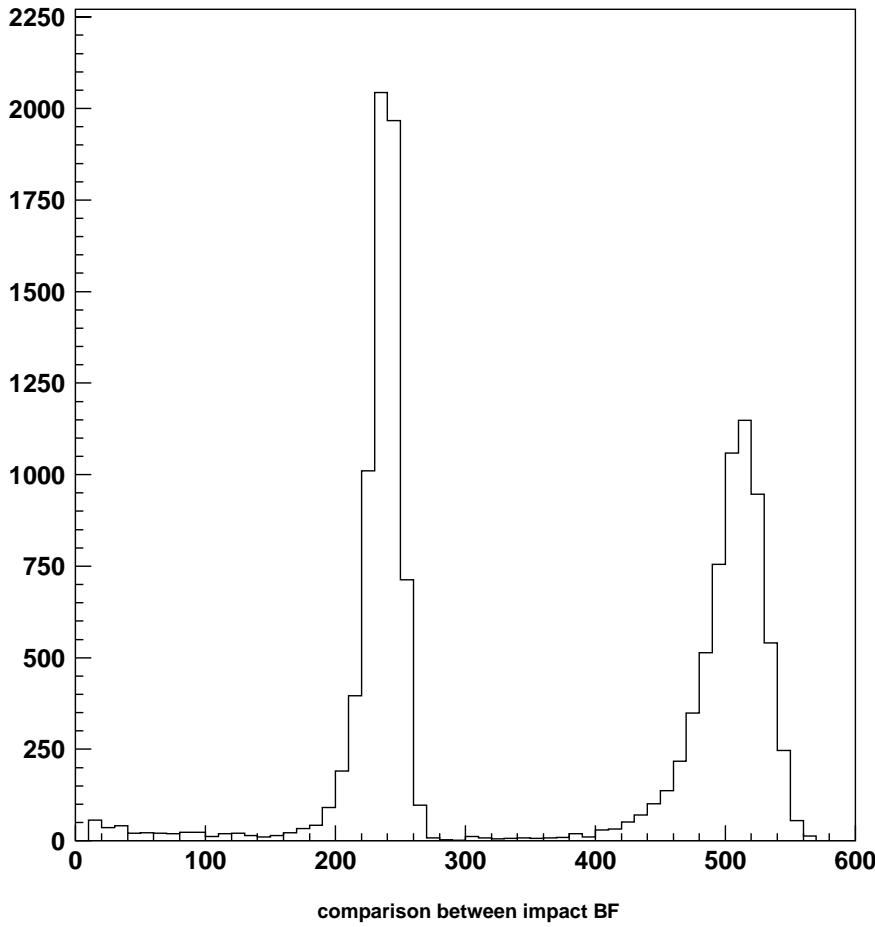
Electron Data

August 99

Cell 61 Problem

99/10/05 16.37

factor two between cell 6137



This figure shows two superimposed signal(adc) distributions:

- Left peak: 100 GeV e^+ on cell 61 only
- Right peak: 100 GeV e^+ on cell 37 only

Both cell 37 and 61 are on the front face

Cell 61 is just above cell 37, hence on the same module.

Factor of 2 required for cell 61... H.V.?? Gain??

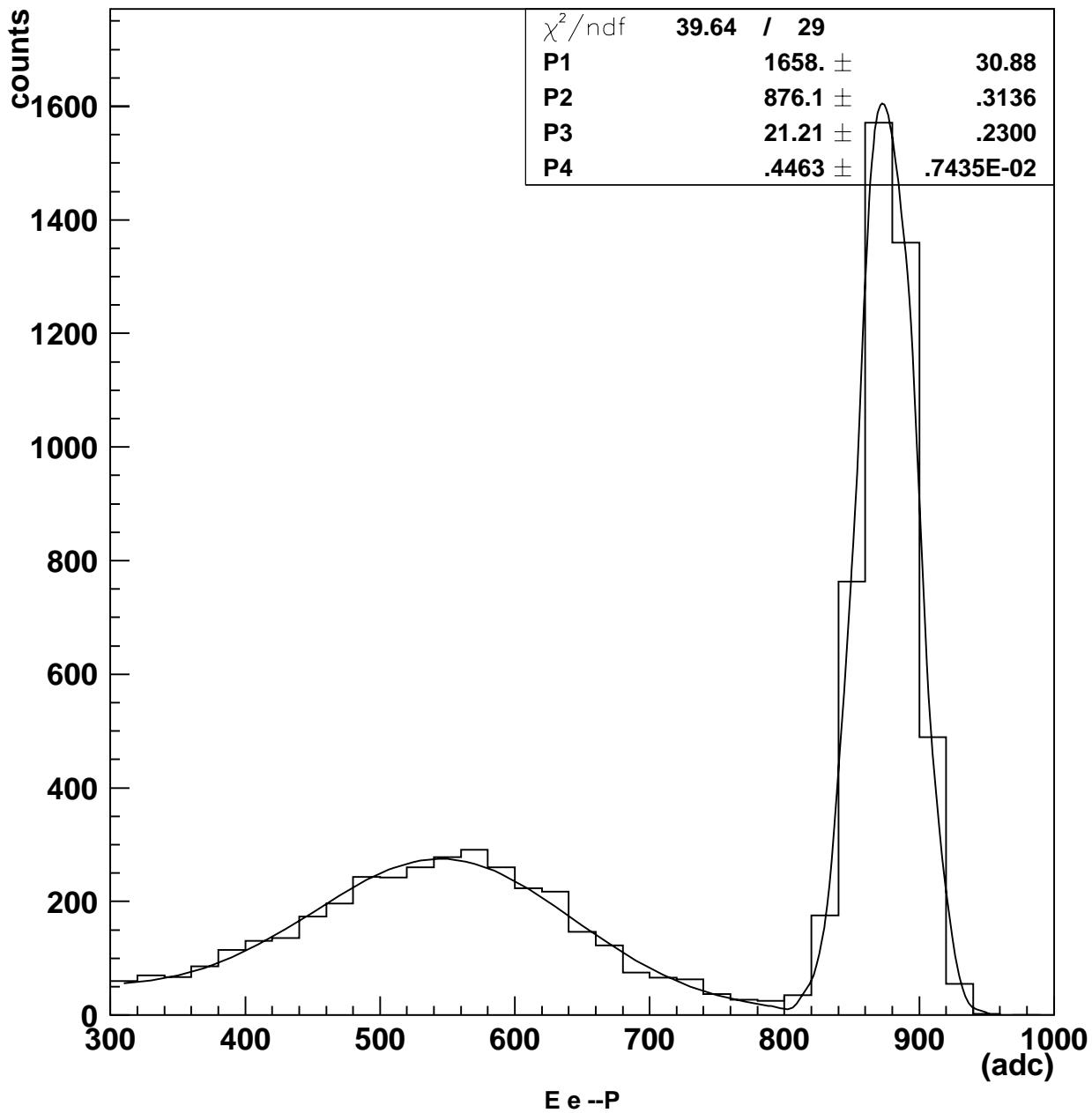
Electron Data

August 99

π^+ contamination in e^+

1999/09/07 16.45

Pion fit, impact point fp is used



Signal(adc) distribution for 147.8 GeV e^+ data
 The shape of the pion contribution was obtained from pion data

We find that the contamination has a negligible effect on the electron peak position